

<b>Notice of References Cited</b>	Application/Control No. 09/827,476	Applicant(s)/Patent Under Reexamination IDE ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,292,802	09-2001	Kessenich et al.	707/101
	B	US-6,421,733	07-2002	Tso et al.	709/246
	C	US-6,101,510	08-2000	Stone et al.	715/513
	D	US-5,745,908	04-1998	Anderson et al.	715/513
	E	US-2004/0143792	07-2004	Demopoulos et al.	715/513
	F	US-6,415,307	07-2002	Jones et al.	715/525
	G	US-5,724,556	03-1998	Souder et al.	703/2
	H	US-6,684,088	01-2004	Halahmi, Erez	455/566
	I	US-5,838,927	11-1998	Gillon et al.	709/247
	J	US-2003/0212686	11-2003	Chu-Carroll et al.	707/100
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	60,190,428
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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